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> Developing Processing Techniques for Skylab Data Monthly Progress Report, May 1974

> > EREP Investigation 456 M NASA Contract NAS9-13280

> > > Prepared by

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Developing Processing Techniques for Skylab Data Monthly Progress Report, May 1974

The following report serves as the fifteenth monthly progress report for EREP Investigation 456M which is entitled "Developing Processing Techniques for Skylab Data". The financial report for this contract (NAS9-13280) is being submitted under separate cover.

The purpose of this investigation is to test information extraction techniques for SKYLAB S-192 data and compare with results obtained in applying these techniques to ERTS and aircraft scanner data.

During this report period the computer program to convert the Universal Format S-192 products to ERIM format was written and debugged. In addition to the programming effort we began familiarizing ourselves with the Michigan Test Site as represented in digital graymaps of S-192 data generated as part of an EOS System Study being carried out at ERIM. This effort was in anticipation of receipt of approval for processing the above S-192 data as part of this investigation. It is hoped that approval will be forthcoming during the next reporting period so that the technical effort can begin in earnest.

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